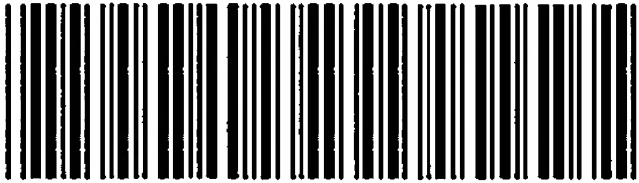


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/618,140	CHIN, ALBERT K.	
	Examiner	Art Unit	
	Amy T. Lang	3731	

SEARCHED			
Class	Subclass	Date	Examiner
606	129		
	198		
	41		
600	37		
	16-18		
	374		
	471		
128	898		
607	122		
	101		
	116		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search	11/25/2007	ATL
EAST keyword search	11/25/2007	ATL
606/129,198,41; 600/16-18,374,471; 128/898; 607/122,101,116 (text delimited search)	11/25/2007	ATL
STIC search report	11/25/2007	ATL